

Search Notes

Application/Control No.

10/526,426

Examiner

Huyen Le

Applicant(s)/Patent under
Reexamination

LIM, CHANG-SHIK

Art Unit

3751

SEARCHED

Class	Subclass	Date	Examiner
4	313 324 325 406 407 DIG 3	12/7/2005	HL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PGPUB		12/7/2005	HL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted w/ Bob Fetsuga	12/7/2005	HL